

ISL9R860PF2

8A, 600V Stealth™ Diode

General Description

The ISL9R860PF2 is a Stealth™ diode optimized for low loss performance in high frequency hard switched applications. The Stealth™ family exhibits low reverse recovery current (I_{RRM}) and exceptionally soft recovery under typical operating conditions.

This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low I_{RRM} and short t_a phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the Stealth™ diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

Formerly developmental type TA49409.

Features

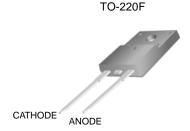
•	Soft Recovery t_b / t_a > 1.2
•	Fast Recovery t_{rr} < 25ns
•	Operating Temperature
•	Reverse Voltage 600V
•	Internally Isolated 1kV

• Avalanche Energy Rated

Applications

- Switch Mode Power Supplies
- · Hard Switched PFC Boost Diode
- · UPS Free Wheeling Diode
- · Motor Drive FWD
- SMPS FWD
- Snubber Diode

Package Symbol





Device Maximum Ratings T_C= 25°C unless otherwise noted

Symbol	Symbol Parameter		Units
V_{RRM}	Peak Repetitive Reverse Voltage	600	V
V _{RWM}	Working Peak Reverse Voltage	600	V
V _R	DC Blocking Voltage	600	V
I _{F(AV)}	Average Rectified Forward Current (T _C = 75°C)	8	Α
I _{FRM}	Repetitive Peak Surge Current (20kHz Square Wave)	16	Α
I _{FSM}	Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	100	Α
P _D	Power Dissipation	26	W
E _{AVL}	Avalanche Energy (1A, 40mH)	20	mJ
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to 150	°C
T _L	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s	300	°C

CAUTION: Stresses above those listed in "Device Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Device	Marking	Device	Package	Tape Width)		Quar	ntity
R860PF2		ISL9R860PF2	TO-220F	N/A			50 Units	
Electric	cal Char	racteristics τ _c = 25°C	unless otherwis	e noted				
Symbol		Parameter	Test	st Conditions Min		Тур	Max	Units
Off State	Charact	eristics						
I _R	Instantaneous Reverse Current		V _R = 600V	$V_{R} = 600V$ $T_{C} = 25^{\circ}C$		-	100	μА
K				T _C = 125°C	-	-	1.0	mA
n State	Characte	eristics	-	1 -	Į.			,I
V _F	Instantaneous Forward Voltage	I _F = 8A	T _C = 25°C	_	2.0	2.4	V	
٧.	motantano	ous i orward voltage	1F = 0/1	T _C = 125°C	_	1.6	2.0	V
	Charact		V - 10V I - 0	.	_	20	I	nE.
СЈ	Junction C	apacitance	$V_{R} = 10V, I_{F} = 0$	$V_R = 10V, I_F = 0A$		30	-	pF
Switchin	g Charac	eteristics						
t _{rr}	"		$I_F = 1A$, $dI_F/dt = 100A/\mu s$, $V_R = 30V$		-	18	25	ns
			$I_F = 8A$, $dI_F/dt =$	= 8A, $dI_F/dt = 100A/\mu s$, $V_R = 30V$ -		21	30	ns
t _{rr}	Reverse R	ecovery Time	$I_F = 8A,$ $dI_F/dt = 200A/\mu s,$		-	28	-	ns
I _{RRM}	Maximum	Reverse Recovery Current			-	3.2	-	Α
Q _{RR}	Reverse R	ecovery Charge	$V_R = 390V, T_C = 25C$		-	50	-	nC
t _{rr}	Reverse R	ecovery Time	$I_{C} = 125^{\circ}C$ $I_{F} = 8A,$ $dI_{F}/dt = 600A/\mu s,$		-	77	-	ns
S	Softness F	actor (t _b /t _a)			-	3.7	-	
I _{RRM}	Maximum	Reverse Recovery Current			-	3.4	-	Α
Q_{RR}	Reverse R	ecovery Charge			-	150	-	nC
t _{rr}	Reverse R	ecovery Time			-	53	-	ns
S	Softness F	actor (t _b /t _a)			-	2.5	-	
I _{RRM}	Maximum	Reverse Recovery Current			-	6.5	-	Α
Q _{RR}	Reverse R	ecovery Charge				195	-	nC
dl _M /dt	Maximum	di/dt during t _b			-	500	-	A/µs
hermal	Characte	eristics						
$R_{\theta JC}$	Thermal R	esistance Junction to Case			-	-	4.8	°C/W
	1		ent TO-220F					

Typical Performance Curves

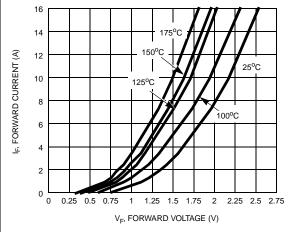


Figure 1. Forward Current vs Forward Voltage

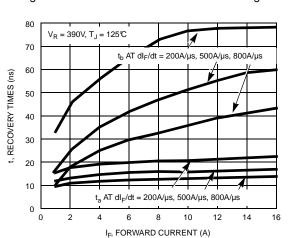


Figure 3. t_a and t_b Curves vs Forward Current

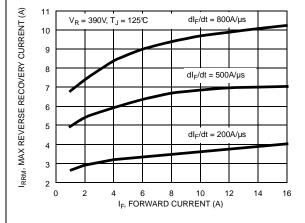


Figure 5. Maximum Reverse Recovery Current vs Forward Current

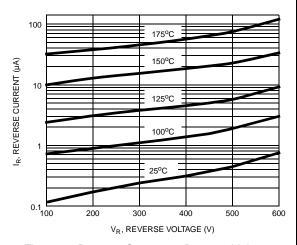


Figure 2. Reverse Current vs Reverse Voltage

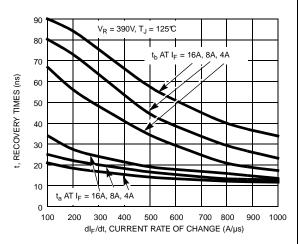


Figure 4. t_a and t_b Curves vs dI_F/dt

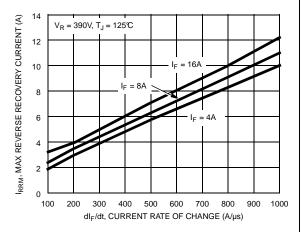
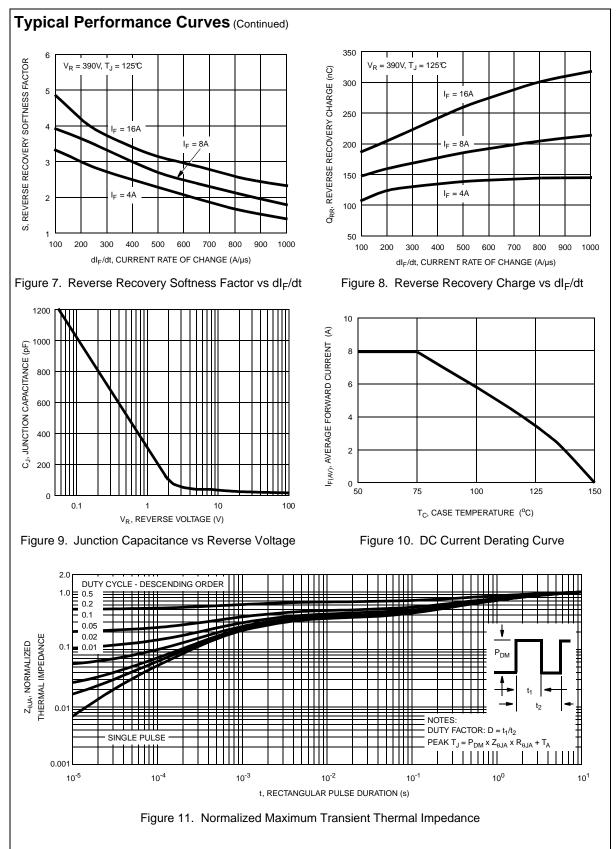


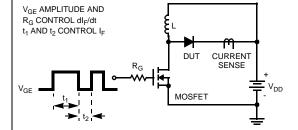
Figure 6. Maximum Reverse Recovery Current vs dI_F/dt

©2003 Fairchild Semiconductor Corporation ISL9R860PF2 Rev. A



©2003 Fairchild Semiconductor Corporation ISL9R860PF2 Rev. A

Test Circuits and Waveforms



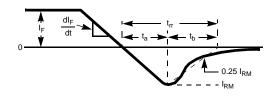


Figure 12. t_{rr} Test Circuit

Figure 13. t_{rr} Waveforms and Definitions

```
I = 1A
L = 40mH
R < 0.1\Omega
V_{DD} = 50V
E_{AVL} = 1/2Ll^2 \left[V_{R(AVL)}/(V_{R(AVL)} - V_{DD})\right]
Q_1 = IGBT \left(BV_{CES} > DUT V_{R(AVL)}\right)
CURRENT
SENSE
V_{DD}
UT
```

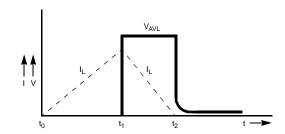


Figure 14. Avalanche Energy Test Circuit

Figure 15. Avalanche Current and Voltage Waveforms

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ImpliedDisconnect™	PACMAN™	SPM™
ISOPLANAR™	POP™	Stealth™
LittleFET™	Power247™	SuperSOT™-3
MicroFET™	PowerTrench®	SuperSOT™-6
MicroPak™	QFET™	SuperSOT™-8
MICROWIRE™	QS™	SyncFET™
MSX™	QT Optoelectronics™	TinyLogic [®]
MSXPro™	Quiet Series™	TruTranslation™
OCX^{TM}	RapidConfigure™	UHC™
OCXPro™	RapidConnect™	UltraFET [®]
OPTOLOGIC®	SILENT SWITCHER®	VCX™
OPTOPLANAR™	SMART START™	
	ISOPLANAR™ LittleFET™ MicroFET™ MicroPak™ MICROWIRE™ MSX™ MSXPro™ OCX™ OCXPro™ OPTOLOGIC®	LittleFETTM Power247TM MicroFETTM PowerTrench® MicroPakTM QFETTM MICROWIRETM QSTM MSXTM QT OptoelectronicsTM MSXProTM Quiet SeriesTM OCXTM RapidConfigureTM OCXProTM RapidConnectTM OPTOLOGIC® SILENT SWITCHER®

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.